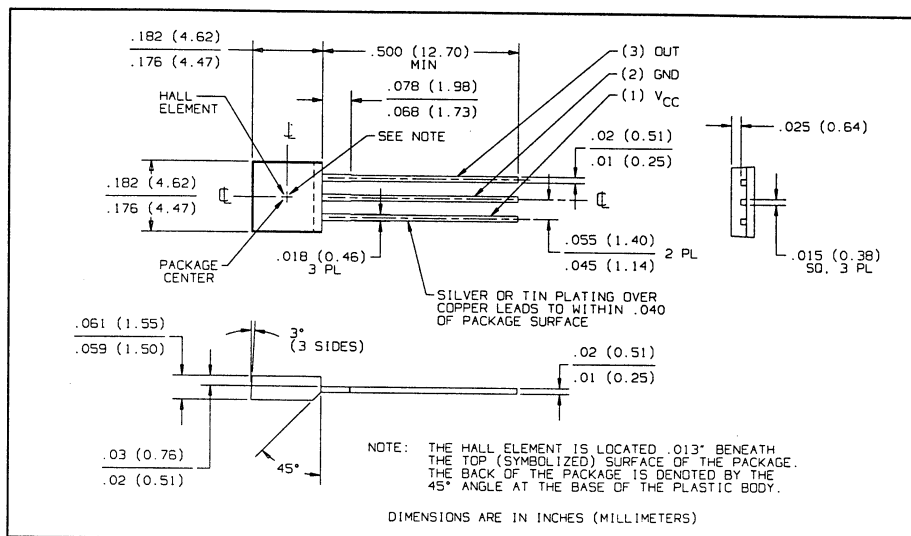
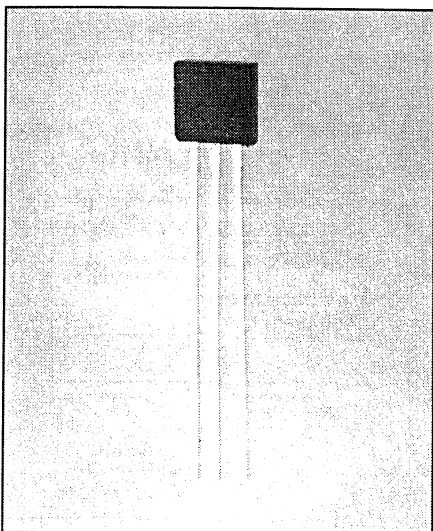


Hallogic® Hall Effect Sensors

Types OHN3040U, OHS3040U



Features

- Operates over a broad range of supply voltages
- Excellent temperature stability to operate in harsh environments
- Drive capability up to 7 TTL loads
- Hall element, linear amplifier, and Schmitt trigger on a single Hallogic® silicon chip

Description

The OHN3040U and OHS3040U each contain a monolithic integrated circuit which incorporates a Hall element, a linear amplifier, and Schmitt trigger on a single silicon chip. Included on-chip is a bandgap voltage regulator to allow operation with a wide range of supply voltages. The devices feature logic level output and provides up to 21 mA of sink current. This allows direct driving of more than 7 TTL loads or any standard logic family using power supplies ranging from 4.5 to 24 volts. Output amplitude is constant at switching frequencies from DC to over 200 kHz.

Stability of the magnetic operate and release points is excellent over this entire temperature range. The release point over the temperature range will always be greater than zero.

Package size has been kept to minimum, providing an advantage in applications where space is limited.

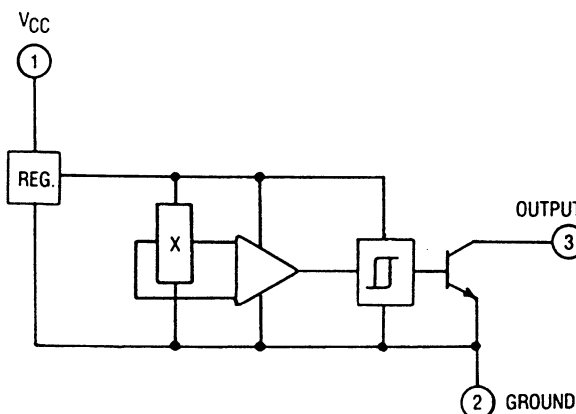
Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Supply Voltage, V_{CC}	25 V
Storage Temperature Range, T_S	-65°C to $+150^\circ\text{C}$
Operating Temperature Range, T_A OHN3040U	-20°C to $+85^\circ\text{C}$
OHS3040U	-40°C to $+125^\circ\text{C}$
Lead Soldering Temperature [1/8 inch (3.2 mm) from case for 5 sec. with soldering iron]	$260^\circ\text{C}^{(1)}$
Output ON Current, I_{SINK}	25 mA
Output OFF Voltage, V_{OUT}	25 V
Magnetic Flux Density, B	Unlimited

Note:

(1) Heat sink leads during hand soldering.

Functional Block Diagram



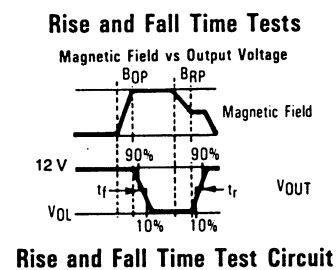
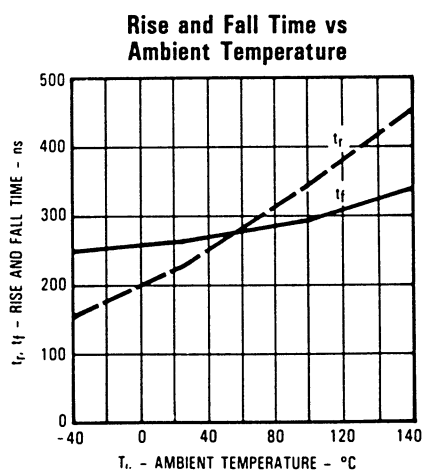
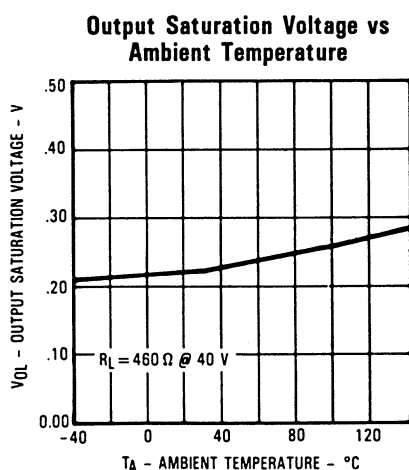
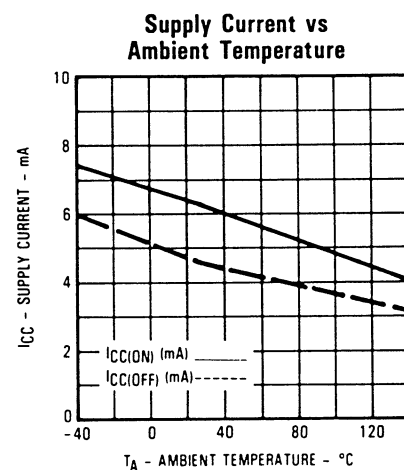
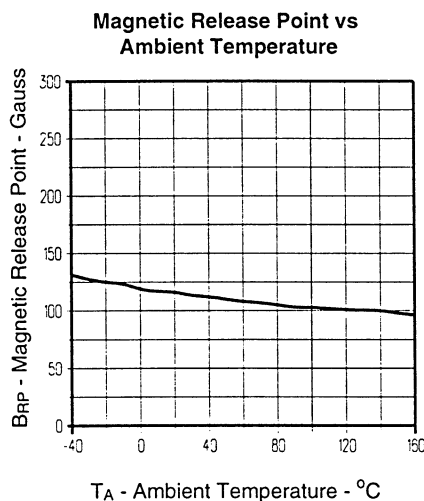
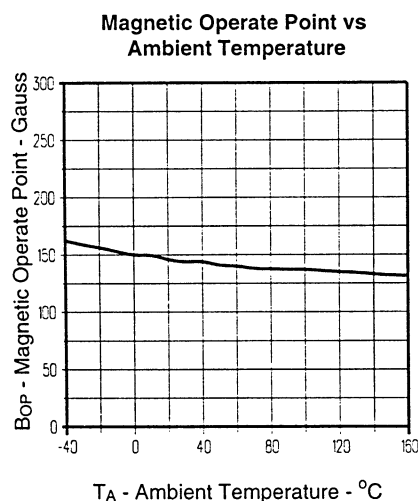
Types OHN3040U, OHS3040U

Electrical Characteristics ($V_{CC} = 4.5 \text{ V to } 24 \text{ V}$, $T_A = 25^\circ \text{ C}$ unless otherwise noted)

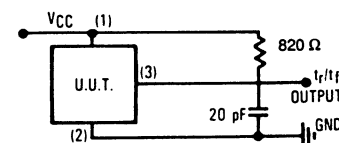
SYMBOL	PARAMETER	MIN	TYP	MAX	UNITS	TEST CONDITIONS
B _{OP}	Magnetic Operate Point ⁽²⁾		150	200	Gauss	
B _{RP}	Magnetic Release Point	50	115		Gauss	
B _H	Magnetic Hysteresis	20	35		Gauss	
I _{CC}	Supply Current		4	7	mA	$V_{CC} = 24 \text{ V}$, Output Off
V _{OL}	Output Saturation Voltage		100	400	mV	$V_{CC} = 4.5 \text{ V}$, $I_{OL} = 20 \text{ mA}$, $B \geq 200 \text{ Gauss}$
I _{OH}	Output Leakage Current		0.1	10.0	μA	$V_{CC} = 24 \text{ V}$, $V_{OUT} = 24 \text{ V}$, $B \leq 50 \text{ Gauss}$
t _r	Output Rise Time		0.21	1.00	μs	$R_L = 820 \Omega$, $C_L = 20 \text{ pF}$
t _f	Output Fall Time		0.25	1.00	μs	

(2) South pole facing symbolized surface.

Typical Performance Curves



Rise and Fall Time Test Circuit



HALL EFFECT
SENSORS

Optek reserves the right to make changes at any time in order to improve design and to supply the best product possible.

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